High Differential Efficiency (>60%) Continuous-Wave Operation of 1.3µm InP-Based VCSELs with Sb-Based DBRs

D. Feezell, D.A. Buell, L.A. Johansson, and L.A. Coldren

University of California, Department of Electrical Engineering, ESB Room 3205B, Santa Barbara, CA 93106 Phone: 805-893-5955, Fax: 805-893-4500, Email: <u>feezell@engineering.ucsb.edu</u>

Long-wavelength vertical-cavity surface-emitting lasers (VCSELs) operating in the important telecommunications window of $1.3 - 1.6\mu$ m are attractive light-sources for short to mid-range optical networks. We have previously demonstrated a monolithic all-epitaxial platform utilizing InAlGaAs active regions and AlGaAsSb distributed Bragg reflectors (DBRs) with excellent results at 1.55μ m [1]. Here we demonstrate the first continuous-wave (CW) operation of a 1.3μ m InP-based VCSEL with Sb-based DBRs. These devices achieved world-record CW differential efficiencies for long-wavelength VCSELs of greater than 60% at room-temperature (RT). Furthermore, we demonstrate the first high-speed modulation for any long-wavelength VCSEL with Sb-based DBRs. These advancements verify that the Sb-based DBR technology can yield high-performance devices spanning the entire $1.3 - 1.6\mu$ m wavelength window.

Fig. 1 shows a schematic of the monolithic all-epitaxial VCSEL structure. The device was grown by solid-source molecular beam epitaxy (MBE) in a single growth step and utilizes a thin (350Å) selectively etched tunnel-junction layer to generate efficient optical and electrical confinement. The AlGaAsSb DBRs provide an index contrast of $\Delta n = 0.4$, comparable to GaAs/AlGaAs DBRs. The cavity contains a five quantum-well active region surrounded by InP layers that facilitate current and heat spreading in the device. The total cavity thickness is 4λ . Fig. 2 displays the CW light and voltage vs. current (LIV) curves for a VCSEL device with an 8µm diameter tunnel-junction aperture. CW operation was observed up to 88°C, with an output power >1.5mW at 20°C. These devices lased single-mode at 1.305µm with a side-mode suppression ratio (SMSR) of 46dB, as shown in Fig. 3.

The thin selectively etched tunnel-junction aperture provided low-loss optical confinement, generating the high differential efficiencies demonstrated in Fig. 4. World-record values were achieved, with 64% at RT and greater than 50% at 50°C. This result is an important advancement towards creating higher power devices with low-required drive-currents. Fig. 5 shows the threshold current vs. stage temperature for the device, indicating that the optimal gain-peak to cavity-mode alignment occurred around 20°C. These devices were designed for optimal RT operation, but improved temperature performance can be expected with a higher gain offset.

In order to demonstrate the high speed capabilities of these devices, they were modulated with a 2^{31} -1 prbs at 3.125Gb/s. Light was coupled directly into a single-mode fiber and then into a 10Gb optical receiver. Open eye diagrams were obtained up to 60°C and are shown in Fig. 6. The extinction ratios were derived directly from the optical bit stream and were >8dB for operation up to 60°C with a peak-to-peak drive voltage of only 800mV. Error-free operation was obtained up to 60°C and the bit error rate (BER) curves are shown in Fig. 7.

In conclusion, we have demonstrated the first CW operation of $1.3\mu m$ VCSELs with Sbbased DBR technology and have achieved record-high CW differential efficiencies. High speed modulation was also demonstrated for the first time with this technology. Coupled with previous results at $1.55\mu m$, these results clearly demonstrate this platform's ability to generate highperformance monolithic VCSELs spanning the entire $1.3 - 1.6\mu m$ wavelength window. [1] S. Nakagawa, et al., *Applied Physics Letters*, vol. 78, pp. 1337-1339 (2001).



Fig. 1: Schematic of 1.3µm InP-based VCSEL device with selectively etched tunnel-junction aperture.



Fig. 3: CW lasing spectrum showing emission at 1.305µm and a 46dB SMSR.



Fig. 4: Differential efficiency vs. stage temperature showing differential efficiency over 50% at 50°C.



Fig. 2: CW LIV curves for bottom-emitting VCSEL with 8µm aperture at various temperatures showing operation up to 88°C.



Fig. 5: Threshold current vs. stage temperature for VCSEL device optimized for RT performance.



Fig. 6: Eye diagrams at 3.125Gb/s for 20, 40, and 60°C. Extinction is >8dB up to 60°C with a drive voltage of 800mV.



Fig. 7: BER curves at 20, 40, and 60° C for a 2^{31} -1 prbs showing error-free operation up to 60° C.